

<b>Notice of References Cited</b>	Application/Control No. 10/527,870		Applicant(s)/Patent Under Reexamination TUKKER ET AL.	
	Examiner Thang V. Tran		Art Unit 2627	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0257961	12-2004	Nishi et al.	369/112.02
*	B	US-2005/0117494	06-2005	Nishi et al.	369/116
*	C	US-6,940,794	09-2005	Hayashi, Hideki	369/47.5
*	D	US-6,791,934	09-2004	Shimano et al.	369/112.23
*	E	US-6,342,976	01-2002	Nomura et al.	359/569
*	F	US-6,166,854	12-2000	Katsuma, Toshiaki	359/569
*	G	US-5,737,299	04-1998	Yoo et al.	369/112.17
*	H	US-5,644,413	07-1997	Komma et al.	369/44.23
*	I	US-5,398,223	03-1995	Tsujioka et al.	369/53.27
*	J	US-4,770,507	09-1988	Arimoto et al.	359/669
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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